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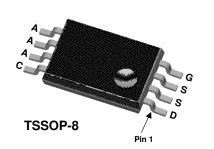
P-Channel 2.5V Specified PowerTrench® MOSFET with Schottky Diode

General Description

This P-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It is combined with a low forward drop Schottky diode which is isolated from the MOSFET, providing a compact power solution for asynchronous DC/DC converter applications.

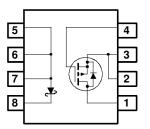
Applications

DC/DC conversion



Features

- -3.5 A, -20 V. $R_{DS(ON)} = 0.045 \ \Omega \ @ V_{GS} = -4.5 \ V$ $R_{DS(ON)} = 0.075 \ \Omega \ @ V_{GS} = -2.5 \ V$
- $V_F < 0.55 V @ 1 A$
- High performance trench technology for extremely low R_{DS(ON)}
- Low profile TSSOP-8 package



MOSFET Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Unit
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		± 12	V
I _D	Drain Current – Continuous	(Note 1)	-3.5	A
	– Pulsed		-30	
D	MOSFET Power Dissipation (minimum p Schottky Power Dissipation (minimum pa		1.2 1.0	W
J, T _{STG}	Operating and Storage Junction Temperation	ature Range	-55 to +150	°C
/ _{RRM} F	Repetitive Peak Reverse Voltage Average Forward Current Peak Forward Current		20 1.5 30	V A A
™ Fherma	I Characteristics			~
R _{eJA}	Thermal Resistance, Junction-to-Ambient (minimum pad) (Note 1)		MOSFET: 115 Schottky: 130	°C/W
Packag	e Marking and Ordering Inf	ormation		
		ormation Reel Size	Tape width	Quantity

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Electrical Characteristics $T_{A} = 25^{\circ}C$ unless otherwise noted Symbol Min Max Units Parameter **Test Conditions** Тур **Off Characteristics** Drain-Source Breakdown Voltage -20 V BV_{DSS} $V_{GS} = 0 V, I_D = -250 \mu A$ Breakdown Voltage Temperature ΔBV_{DSS} $I_D = -250 \ \mu A$, Referenced to $25^{\circ}C$ -16 mV/°C Coefficient ΔT_{\perp} IDSS Zero Gate Voltage Drain Current $V_{DS} = -16 V$, $V_{GS} = 0 V$ -1 μA Gate-Body Leakage, Forward $V_{GS} = -12 V$, $V_{DS} = 0 V$ -100 IGSSF nA $V_{DS} = 0 V$ Gate-Body Leakage, Reverse $V_{GS} = 12 V$, IGSSR 100 nA On Characteristics (Note 2) V V_{GS(th)} Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = -250 \ \mu A$ -0.6 -1.0 -1.5 $\Delta V_{GS(th)}$ Gate Threshold Voltage $I_D = -250 \ \mu A$, Referenced to $25^{\circ}C$ 3 mV/°C **Temperature Coefficient** $\Delta T_{\rm J}$ R_{DS(on)} Static Drain-Source $I_{\rm D} = -3.5 \, \overline{\rm A}$ $V_{GS} = -4.5 V$, 36 45 mΩ On-Resistance $V_{GS} = -2.5 V$, $I_{D} = -2.7 \text{ A}$ 56 75 49 72 V_{GS}=-4.5 V, I_D =-3.5A, T_J=125°C On-State Drain Current $V_{GS} = -4.5 V$, -15 $V_{DS} = -5 V$ I_{D(on)} А Forward Transconductance $V_{DS} = -5 V$, $I_{D} = -3.5A$ S 13.2 **g**_{FS} **Dynamic Characteristics** C_{iss} Input Capacitance $V_{DS} = -10 V$, $V_{GS} = 0 V$, 1030 pF C_{oss} **Output Capacitance** 280 f = 1.0 MHz pF C_{rss} **Reverse Transfer Capacitance** 120 pF Switching Characteristics (Note 2) Turn-On Delay Time $I_{\rm D} = -1 \, {\rm A},$ 20 $V_{DD} = -5 V$, 11 t_{d(on)} ns $V_{GS} = -4.5 V$, $R_{GEN} = 6 \Omega$ Turn-On Rise Time 18 32 tr ns Turn-Off Delay Time 55 34 $t_{d(off)}$ ns Turn-Off Fall Time tf 34 55 ns Qg **Total Gate Charge** $V_{DS} = -5V$, $I_{\rm D} = -3.5 \text{ A},$ 9.7 16 nC $V_{GS} = -4.5 V$ Q_{gs} Gate-Source Charge 2.2 nC Gate-Drain Charge 2.4 Q_{gd} nC Drain–Source Diode Characteristics and Maximum Ratings ls Maximum Continuous Drain-Source Diode Forward Current -1.25 А V_{SD} Drain-Source Diode Forward $V_{GS} = 0 V$, $I_S = -1.25 A$ (Note 2) ٧ -0.6 -1.2 Voltage Gate-Body Leakage, Reverse $V_{GS} = 12 V_{,}$ $V_{DS} = 0 V$ 100 IGSSB nA Schottky Diode Characteristics 0.6 50 Reverse Leakage $V_{\text{R}} = 20V$ TJ=25°C μΑ I_R TJ=125°C 8 1 mA VF 0.48 Forward Voltage $I_F = 1A$ TJ=25°C 0.55 ٧ T_J=125°C 0.42 0.50 V pF CT Junction Capacitance $V_{\rm R} = 10V$ 50

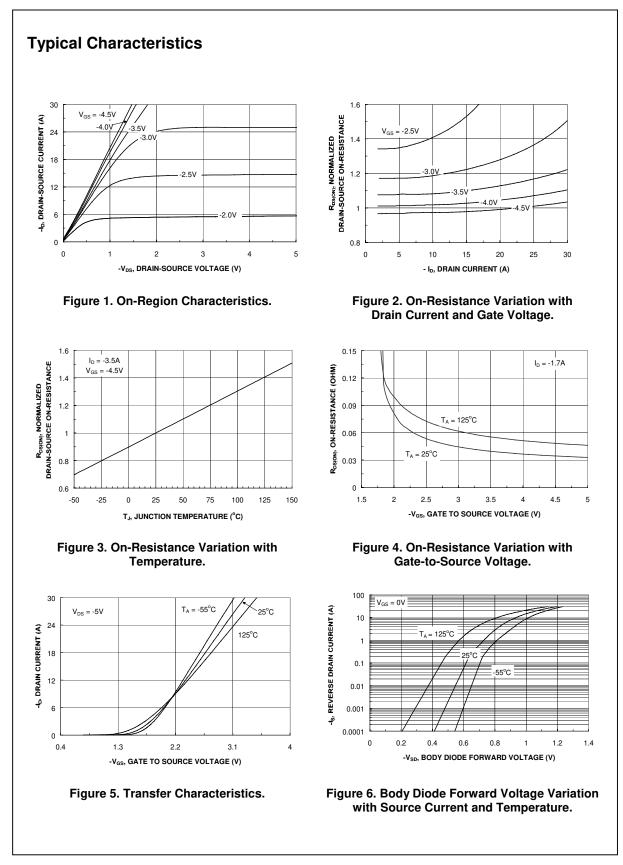
Notes:

1. $R_{e,IA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{e,IC}$ is guaranteed by design while R_{eCA} is determined by the user's board design.

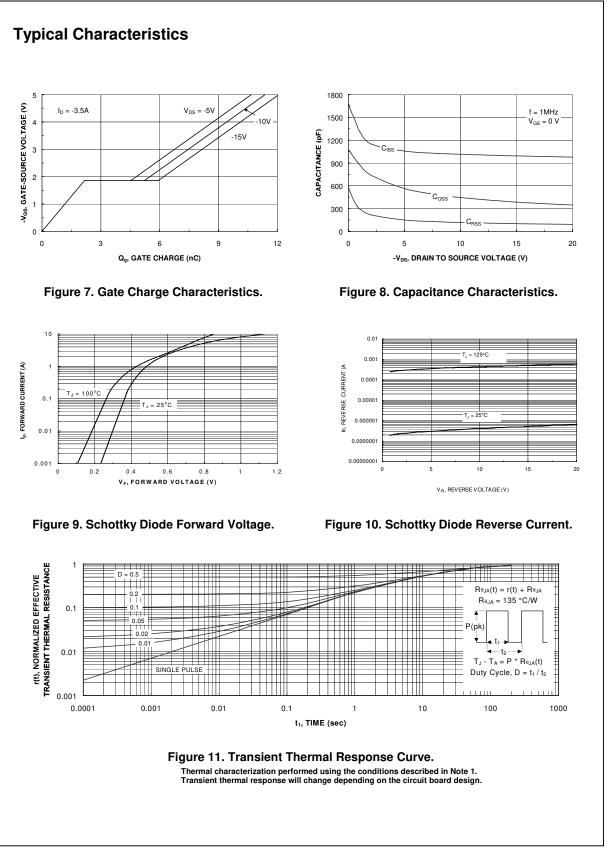
R_{6.IA} is 115 °C/W for the MOSFET and 130°C/W for the Schottky Diode when mounted on a minimum pad.

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

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